

Search Notes

Application/Control No.

10/728,689

Examiner

VIJAY SHANKAR

Applicant(s)/Patent under
Reexamination

ENMEI, TOSHIHARU

Art Unit

2673

SEARCHED

Class	Subclass	Date	Examiner
345	156-158, 169, 173-179	1/4/2006	VS
178	18.01-.07		
178	19.01-.06		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
SAME	AS ABOVE	1/7/2006	VS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTOR NAME SEARCH	1/7/2006	VS